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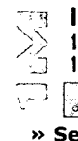| Set Name side by side	Query	Hit Count	Set Name result set
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Seungkyoon Woo; Myoung Ho Kim; Yoon Joon Lee;
Database Engineering and Applications Symposium, 1997. IDEAS '97. Proceedings., International , 25-27 Aug. 1997
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[Abstract]   [PDF Full-Text (820 KB)]   **IEEE CNF**

2 **Log-driven backups: A recovery scheme for large memory database systems**
Levy, E.; Silberschatz, A.;
Information Technology, 1990. 'Next Decade in Information Technology', Proceedings of the 5th Jerusalem Conference on (Cat. No.90TH0326-9) , 22-2 Oct. 1990
Pages:99 - 109

[Abstract]   [PDF Full-Text (880 KB)]   **IEEE CNF**

3 **Log-structured file systems**
Douglis, F.; Ousterhout, J.;
COMPCON Spring '89. Thirty-Fourth IEEE Computer Society International Conference: Intellectual Leverage, Digest of Papers. , 27 Feb.-3 March 1989
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[Abstract]   [PDF Full-Text (504 KB)]   **IEEE CNF**

4 **Cleaning up the clutter: why web standards matter [Web design]**
Macmichael, R.A.;
IT Professional , Volume: 6 , Issue: 2 , March-April 2004

Pages:62 - 63

[Abstract]   [PDF Full-Text (396 KB)]   **IEEE JNL**

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5 Flicker c rrecti n f r archived film sequences using a nonlinear moc
Vlachos, T.;
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Kexiang Hu; Mehrotra, S.; Kaplan, S.;
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Pages:161 - 167

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Mi-Seon Choi; Hye-Sook Yoon; Eun-Mi Song; Young-Keol Kim; Young-Kuk Kin Soong-Il Jin; Mi-Kyong Han; Wan Choi;
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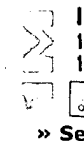
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